

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BUCHANAN ET AL.	
		Examiner Leigh C. Maier	Art Unit 1623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 59-58026	04-1984	Japan	NIPPON SYNTHETIC CHEM	----
	O					
	P					
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	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	DERWENT abstract of JP 59-58026 (1984).
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